NSN 6625-01-257-5258

Semiconductor Device Test Set - Page 1 of 1



View Online at https://aerobasegroup.com/nsn/6625-01-257-5258 Width: 19.000 inches Ac Voltage Rating: 110.0 volts and 125.0 volts and 216.0 volts and 250.0 volts Frequency Rating: Between 50.0 hertz and 60.0 hertz Depth: 25.000 inches **Electrical Power Source Relationship:** Operating Inclosure Feature: Single item w/housing **Test Type For Which Designed:** Microcomputer controlled ram based test system for high throughput testing of the full range of linear devices **Special Features:** Display includes both pass/fail led and a range of video display modes; includes keyboard and mass storage; rs232 and ieee-488 interfaces Height: 12.500 inches **Supplementary Features:** Manufacturers name: linear ic test system Shelf Life: N/a **Unit Of Measure: Demilitarization:** No Fiig: T228-a